

Page-23 Flash type (simultaneous type) A/D converter (for 2-bit digital output)

Q.12
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Flash type A/D converter is open-loop and direct type analog-to-digital converter which is based on the technique of comparison of unknown input analog voltage with a set of reference voltages. To convert a range of input analog voltage into n -bit digital output, we need $(2^n - 1)$ comparators. Here we design 2-bit flash type Analog-to-digital converter. For this we need $(2^2 - 1) = 3$ comparators. The fig-1 shows a block diagram of 2-bit flash type A/D converter. Since we have to convert analog input into 2-bit digital output, hence we need ~~2~~ $2^2 - 1 = 3$ discrete level of reference voltages as $\frac{V}{4}$, $\frac{2V}{4}$, $\frac{3V}{4}$ as shown in fig-1.

As illustrated in fig-1, three op-amp are used here as comparators. The inverting terminal of op-amp-1, 2, 3 are connected with reference voltages as $\frac{V}{4}$, $\frac{2V}{4}$, $\frac{3V}{4}$ respectively - which are

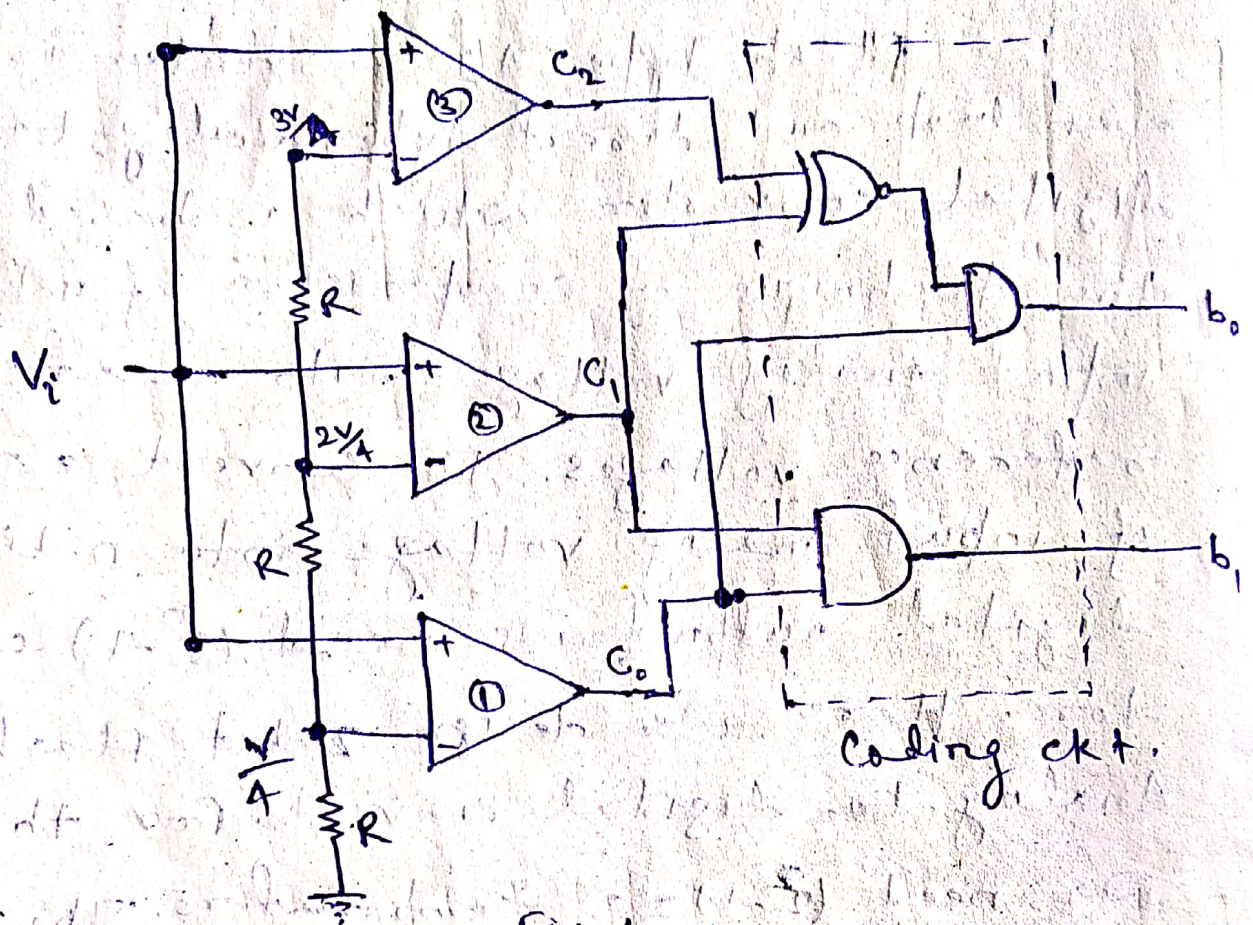


Fig-1

obtained by voltage divider ckt.

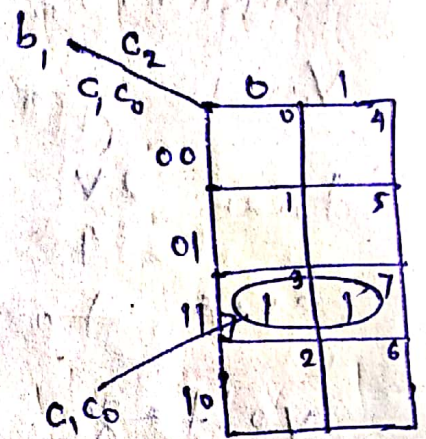
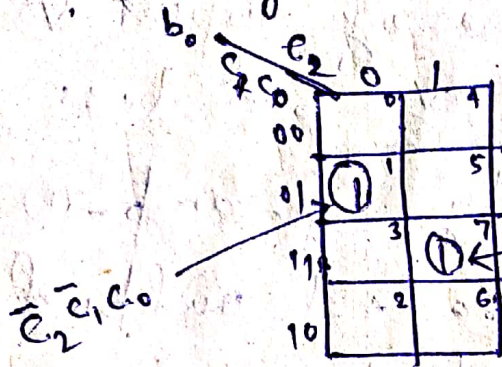
The analog input voltage that is to be converted into digital signal, is supplied to non-inverting terminal of all three op-amp.

Working:- When, input voltage V_i is less than the reference voltage $V/4$ (at inverting terminal), all the op-amp (which are used as comparators), gives output as negative saturated voltage.

and assumed as LOW. Thus, in this case, $C_2, C_1, C_0 = 000$. Again, when unknown applied analog input voltage V_i is greater than $\frac{V}{4}$ but less than $\frac{2V}{4}$ then only, op-amp-① goes to +ve saturated output voltage which treated as HIGH, but op-amp-② & ③ gives a -ve saturated voltage which are treated as LOW. Thus, comparators output is $C_2, C_1, C_0 = 001$. Thus obtained comparators are encoded by using digital coding ckt which are shown in fig-4 by dotted box. The entire working function and comparators output can be listed as below in table.

Analog input (V_i)	Comparator o/p			Digital o/p	
	C_2	C_1	C_0	b_1	b_0
$0 \leq V_i \leq \frac{V}{4}$	0 (Low)	0 (Low)	0 (Low)	0	0
$\frac{V}{4} \leq V_i \leq \frac{2V}{4}$	0	0	1 High	0	1
$\frac{2V}{4} \leq V_i \leq \frac{3V}{4}$	0	1	1	1	0
$\frac{3V}{4} \leq V_i \leq V$	1	1	1	1	1

By using K-map, we can design the coding digital ckt as below —



$$\begin{aligned} b_0 &= c_2 c_1 c_0 + \bar{c}_2 \bar{c}_1 c_0 \\ &= (c_2 c_1 + \bar{c}_2 \bar{c}_1) c_0 \\ &= c_0 (c_2 \oplus \bar{c}_1) \end{aligned}$$

$$b_1 = c_1 c_0$$

3-bit Flash type (or simultaneous type) A/D

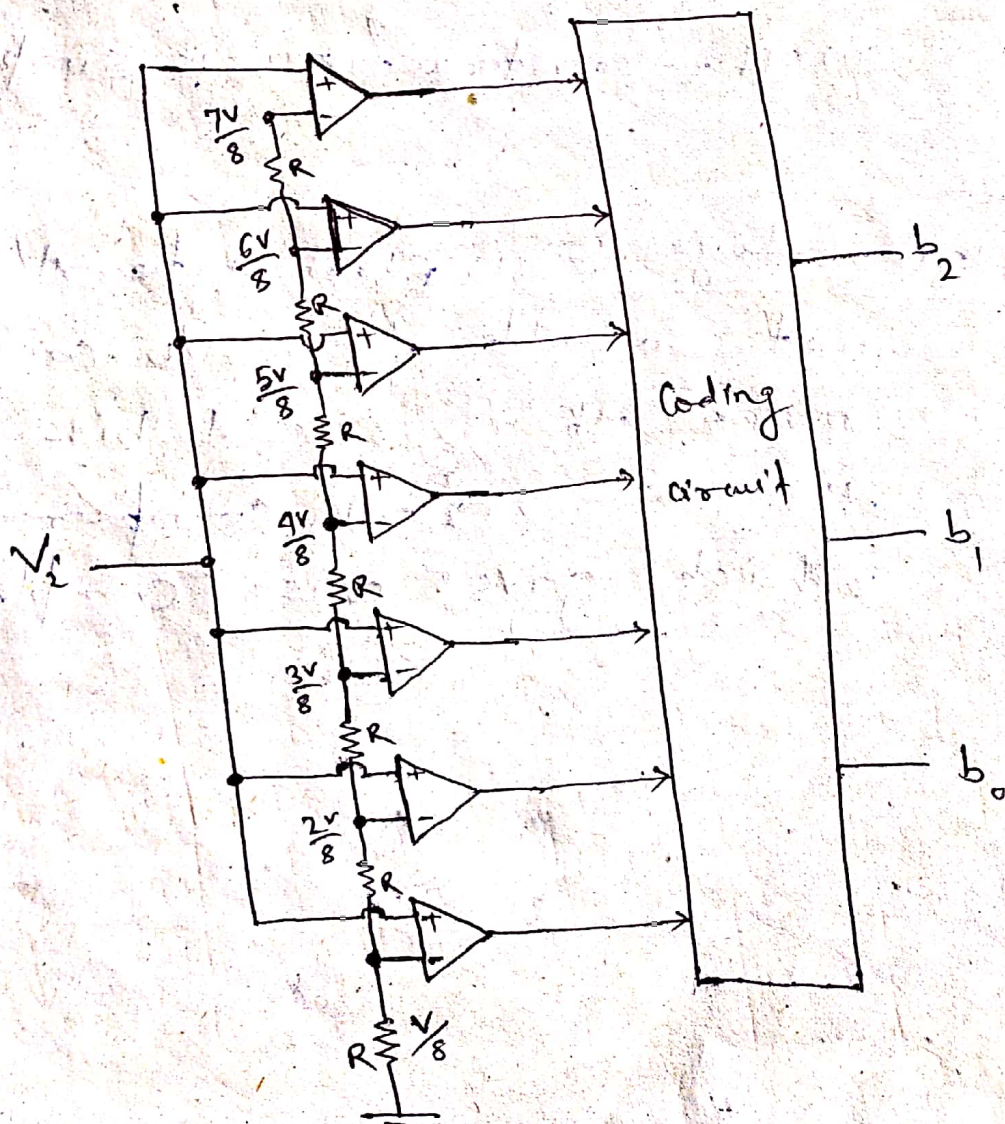
3-bit simultaneous type A/D converter, converts the entire analog input voltage into 3-bit digital word by comparison of input analog voltage with $\frac{V}{2^3}, \frac{2V}{8}, \frac{3V}{8}, \frac{4V}{8}, \frac{5V}{8}, \frac{6V}{8}, \frac{7V}{8}$. For designing 3-bit flash type A/D converter, we need $2^3 - 1 = 7$ comparators.

The reference voltages to which input analog voltage is to be compared and comparators output as $c_0, c_1, c_2, c_3, c_4, c_5, c_6, c_7$ are listed in table-1. Fig-① shows 3-bit Flash type A/D converter.

Comparator output

Input voltage
$0 \leq V_i \leq \frac{V}{8}$
$\frac{V}{8} \leq V_i \leq \frac{2V}{8}$
$\frac{2V}{8} \leq V_i \leq \frac{3V}{8}$
$\frac{3V}{8} \leq V_i \leq \frac{4V}{8}$
$\frac{4V}{8} \leq V_i \leq \frac{5V}{8}$
$\frac{5V}{8} \leq V_i \leq \frac{6V}{8}$
$\frac{6V}{8} \leq V_i \leq \frac{7V}{8}$
$\frac{7V}{8} \leq V_i \leq V$

Comparator output							Digital o/p		
c_6	c_5	c_4	c_3	c_2	c_1	c_0	b_2	b_1	b_0
0	0	0	0	0	0	0	0	0	0
0	0	0	0	0	0	1	0	0	1
0	0	0	0	0	1	1	0	1	0
0	0	0	0	1	1	1	0	1	1
0	0	0	1	1	1	1	1	0	0
0	0	1	1	1	1	1	1	0	1
0	1	1	1	1	1	1	1	1	0
1	1	1	1	1	1	1	1	1	1



[Fig-4]

Fig-4. represents the logic ckt diagram of a 3-bit simultaneous type A/D (or Flash type A/D) converter.

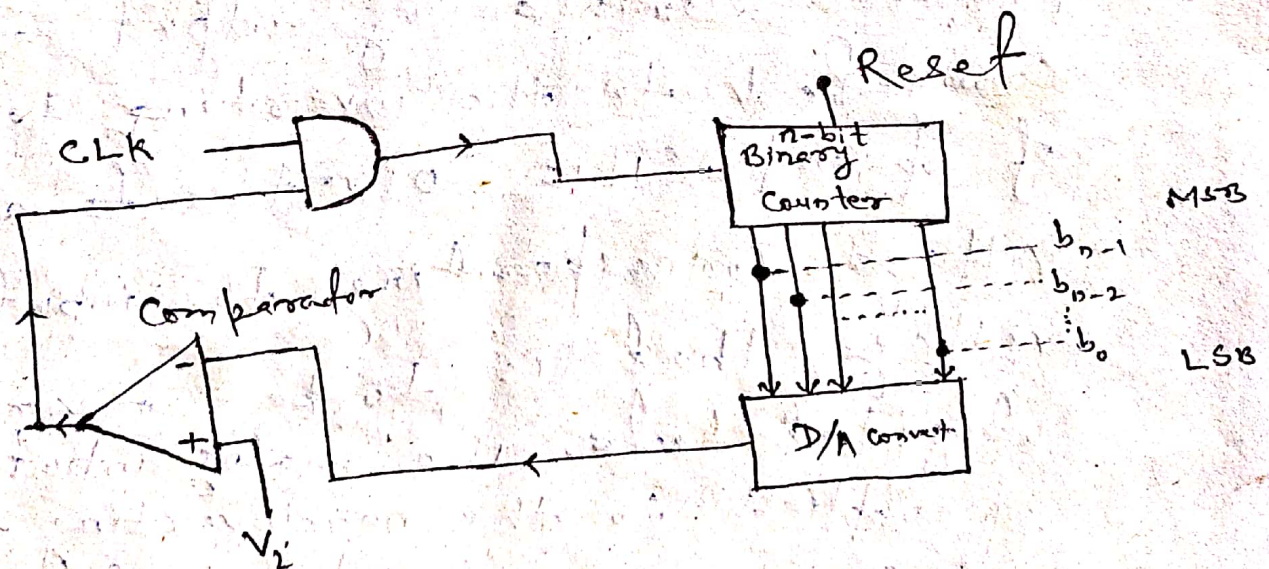
Advantages:- (i) Flash type A/D converter is the fastest because in this converter, the conversion is performed simultaneously through a set of comparators. A type conversion time is 100ns or less.

(ii) The construction is simple and easier.

Disadvantages:- (i) Flash type A/D converter is not suitable for A/D conversion with more than 3 or 4 bits. Because we need $(2^n - 1)$ comparators to design which gives rise complexity.

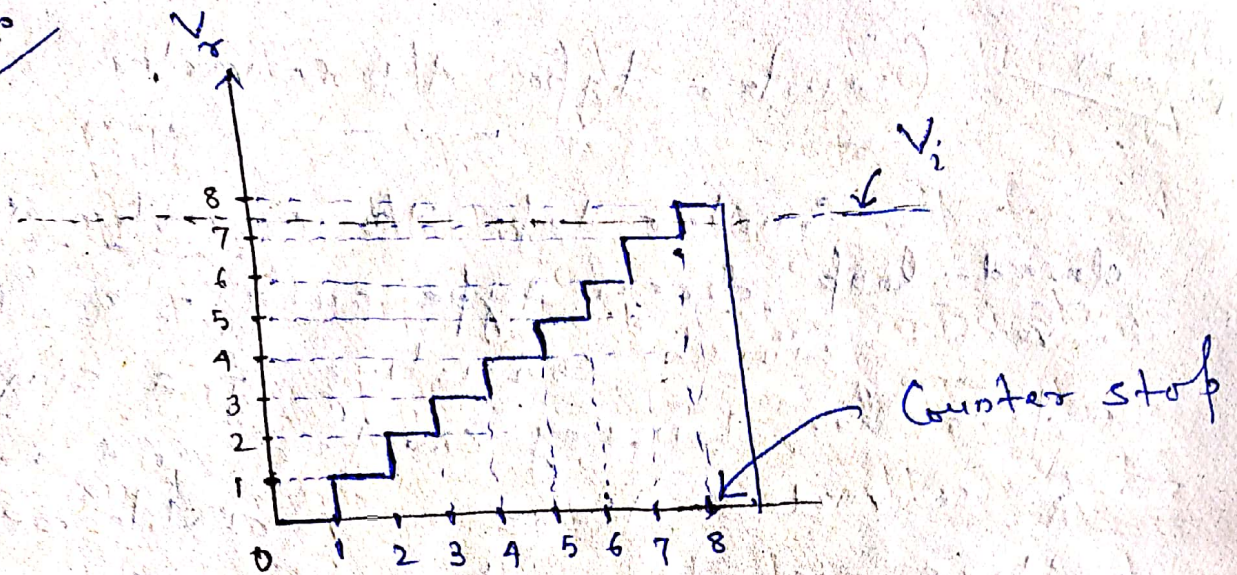
Counter type A/D converter

Counter type A/D converter is a closed-loop direct type analog-to-digital converter which consists of a single comparator, binary counter and a D/A converter. Here a variable reference voltage is obtained by using binary counter and input analog signal is compared with this variable reference voltage and then digital data is produced correspondingly. The fig-1 shows a basic block diagram of a counter type A/D converter.



Counter type A/D converter.

Fig-2.



Operation :- The 8-bit binary counter is initially Reset or set to zero by switch RESET. RESET switch is active LOW and, hence counter output is LOW which is given to D/A converter which produces 0 volt analog output and is connected to the inverting terminal of op-amp. This 0 volt acts as reference voltage corresponding to input analog voltage that is to be converted into digital data. The analog input voltage is applied to the non-inverting terminal of op-amp, this op-amp functions as a comparator and output of it, is given to AND gate as shown in fig. A clock pulse is also applied to another terminal of AND gate.

NOTE (for n-bit A/D converter)

Maximum Conversion for n-bit A/D —

i) Successive type — n-clock cycle

ii) Parallel comparator or

Flash type A/D — 1 clock cycle

iii) Dual-slope A/D — 2^n clock cycle

iv) Max^m counts to reach full scale conversion for counter type A/D converter — 2^n counts.

v) Average conversion time for counter type A/D converter — 2^{n-1} time clock period.

• Digital output corresponding to analog input —

$$\sum_{i=0}^{n-1} 2^i b_i = \frac{V_{in}}{\text{Resolution}}, \quad \text{Resolution} = \frac{V_R}{2^n}$$

• 1 LSB = Resolution weight

• Accuracy = $T_{\text{coeff}} \times (T_{\text{max}} - T_{\text{calibration}})$

$$\pm \frac{1}{2} \text{LSB} = T_{\text{coeff}} (T_{\text{max}} - T_{\text{calib}})$$

where

T_{coeff} = Temp. coeff. of A/D converter in %/°C

T_{max} = Max^m temp of operating range

T_{calib} = Calibrated temp. of A/D converter